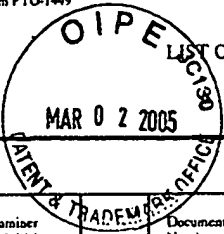


EV371300620

Sheet 1 of 2

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M22-2467		SERIAL NO. 19757,253	
				LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)			
				APPLICANT Derise M. Eppich et al. FILING DATE Jan. 13, 2004 [RCE filed herewith] GROUP 2823			
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
Lee	AA	5,705,428	01/98	Liu et al.			
	AB	6,306,743 B1	10/01	Lee			
	AC	6,436,749 B1	08/02	Tonti et al.			
	AD	6,573,160 B2	06/03	Taylor Jr. et al.			
	AE	6,255,698 B1	07/01	Gardner et al.			
	AF	6,683,333 B1	02/04	Yu			
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AM						
	AN						
	AO						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AP						
	AQ						
	AR						
EXAMINER	DATE CONSIDERED						
Lee	3/24/2005						
*EXAMINER: Initial if reference considered whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

paper NO. : 030205

EV371300620

Form PTO-1449		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY. DOCKET NO. M122-2487		SERIAL NO. 10757,253	
LIST OF ART CITED BY APPLICANT (Use several sheets if necessary)				APPLICANT Derise M. Eppich et al.			
				FILING DATE Jan. 13, 2004 (RCE filed herewith)		GROUP 2823	
U.S. PATENT DOCUMENTS							
*Examiner Initial	Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
Lee	AA	2003/ 0129793 A1	07/03	Chau et al.			
Lee	AB	2004/ 0065903 A1	04/04	Zheng et al.			
Lee	AC	2004/ 0038538 A1	02/04	Ho et al.			
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
FOREIGN PATENT DOCUMENTS							
	Document Number	Date	Country	Class	Subclass	Translation	
						Yes	No
	AJ						
	AK						
	AL						
	AM						
	AN						
OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.)							
	AO						
	AP						
	AQ						
EXAMINER <i>How May Lee</i>		DATE CONSIDERED <i>3/24/2005</i>					
EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

paper NO.: 030205